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/ Ruth Montalvo Date: 08/04/05Customer No. **026418****IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**Attorney's Docket No.: **GK-ZEI-3269/500343.20289**U.S. Application No.: **10/533,603**International Application No.: **PCT/EP2004/006302**International Filing Date: **JUNE 11, 2004****11 JUNE 2004**Priority Date Claimed: **JUNE 12, 2003****12 JUNE 2003**Title of Invention: **METHOD FOR DETERMINING THE IMAGE QUALITY OF AN OPTICAL IMAGING SYSTEM**Applicant(s) for (DO/EO/US): **Thomas ENGEL and Herbert GROSS**

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Commissioner For Patents  
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Alexandria, VA 22313-1450

**SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT****S I R:**

Supplemental to the information Disclosure Statement filed on April 29, 2005, applicants submits copies of the articles AX and AY previously omitted

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

**AX Literature: Joseph Geary, "Wavefront sensors", SPIE Press 1995;**  
**Chapters 3** (pgs 27-51), **4** (pgs 53-65), **5** (pgs 67-87), **6** (pgs 89-103),  
**8** (pgs 125-136) and **10** (pgs 151-167),

**AY Literature: Daniel Malacara, "Optical Shop Testing", Wiley Verlag 1992;**  
**Chapters 8** (pgs 265-314), **10** (pgs 367-396) and **11** (pgs 397-426),.

Accompanying this Supplemental Information Disclosure Statement and Supplemental form PTO-1449 are copies of the articles AX and AY, mentioned on page 3 of the substitute specification.

This submission is not an admission that the information disclosed in the documents is material to the patentability of the invention disclosed and/or claimed in the above-identified application.

Respectfully submitted,

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Enclosures:  
PTO-1449 & Articles;

**ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /M.S./**

LIST OF PRIOR ART CITED BY APPLICANT  
(SUPPLEMENTAL Filed on AUGUST 4, 2005)

Docket No. **GM/ELI-3269/500343.20289**  
Applicant(s): **Thomas ENGEL and Herbert GROSS**  
Application No. **10/533,603**  
Filed: **April 29, 2005**

Group:  
Examiner:

## U.S. PATENT DOCUMENTS

Exam. Init	Document Number	Date	Name	Class	Sub-Class	Filing Date Appropriate
	AA					
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	AJ					
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## FOREIGN PATENT DOCUMENTS

	Document Number	Date	Country	CLASS	Sub-Class	Translation YES	Translation NO
	AL						
	AM						
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	AQ						
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	AT						

## OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

AX	Literature: Joseph Geary, "Wavefront sensors", SPIE Press 1995; Chapters 3 (pgs 27-51), 4 (pgs 53-65), 5 (pgs 67-87), 6 (pgs 89-103), 8 (pgs 125-136), and 10 (pgs 151-167),
AY	Literature: Daniel Malacara, "Optical Shop Testing", Wiley Verlag 1992; Chapters 8 (pgs 265-314), 10 (pgs 367-396) and 11 (pgs 397-426),
AZ	

Examiner: /Manav Seth/ Date: 09/14/2008

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.